Amendments to the Claims

1. (Currently Amended) A method of fabricating an electro-optical device suitable for use in an image forming system, the method comprising the steps of:

imbedding embedding a sensor sensors in a substrate to form a sensor area areas, each sensor area substantially overlying an associated sensor, and a non-sensor area;

depositing a base layer over each sensor area and the non-sensor area;

applying a first filter layer on at least a portion of the substrate inclusive of the non-sensor area to at least partially planarize the device; and

applying a second filter layer over at least a portion of the substrate without removing the first filter layer on from the non-sensor area.

2. (Cancelled)

- 3. (Currently Amended) The method of claim 1, wherein, in the step of applying a the base layer, the base layer is translucent.
- 4. (Currently Amended) The method of claim 1, further comprising the step of mounting the electro-optical device in an the image forming system.
- 5. (Currently Amended) The method of claim 1, wherein, in the steps of applying the <u>filter layers</u>, at least one of the first and second filter layers contains a pigment.
- 6. (Currently Amended) The method of claim 1, further comprising the step of applying a the second filter layer on at least a portion of a second the non-sensor area to at least partially planarize the device.
- 7. (Currently Amended) The method of claim 6, further comprising the step of applying a third filter layer over at least a portion of the substrate without removing the second filter layer on from the second non-sensor area.

8. (Currently Amended) The method of claim 7, wherein, in the steps of applying the <u>filter layers</u>, the first filter layer corresponds to a first primary color, the second filter layer corresponds to a second primary color, and the third filter layer corresponds to a third primary color.

Claims 9 and 10 (Cancelled)

11. (Currently Amended) A method of applying a filter layer of substantially uniform thickness for an image forming system, the method comprising the steps of:

providing a wafer substrate containing at least two photosensors a first photosensor and a second photosensor, the first photosensor positioned closer to a point of an initial filter application than the second photosensor; and

applying a first filter layer on the substrate inclusive of at least a portion of a non-sensor area of the wafer substrate to create an uniform surface for applying to deposit a second filter layer of substantial the substantially uniform thickness over the at least two photosensors, the non-sensor area being an area complimentary to each area overlying each photosensor.

- 12. (Currently Amended) The method of claim 11, further comprising the step of applying a base layer on the wafer substrate before the step of applying the first filter layer.
- 13. (Currently Amended) An electro-optical device suitable for use in an image forming system, the device comprising:
 - a substrate;
 - a sensor embedded in the substrate forming a sensor area and a non-sensor area;
- a first filter layer on at least a portion of the non-sensor area to at least partially planarize the device; and
- a second filter layer applied over at least a portion of the substrate without removing the first filter layer on from the at least a portion of the non-sensor area.
- 14. (Currently Amended) The electro-optical device of device of claim 13, further comprising a base layer on the substrate.

15. (New) A method of fabricating a color sensing semiconductor device comprising: embedding at least a first sensor, a second sensor and a third sensor in a substrate;

the first sensor defining an associated first sensor area, overlying the first sensor, and a first non-sensor area, disposed near the first sensor area;

the second sensor defining an associated second sensor area, overlying the second sensor; the third sensor defining an associated third sensor area, overlying the third sensor, and a second non-sensor area, disposed near the third sensor area;

depositing a first filter layer over the substrate, exclusive of the third sensor area; depositing a second filter layer over the substrate, exclusive of the first sensor area; and depositing a third filter layer over the substrate, exclusive of the second sensor area.

- 16. (New) The method as set forth in claim 15, further including: applying a clear base layer before depositing the first filter layer over the substrate.
- 17. (New) The method as set forth in claim 15, further including: removing the first filter layer from the non-sensor areas after depositing the second filter layer; and

removing the second filter layer from the non-sensor areas after depositing the third filter layer.

18. (New) The method as set forth in claim 15, wherein the first filter layer corresponds to a first subtractive primary color, the second filter layer corresponds to a second subtractive primary color and the third filter layer corresponds to a third subtractive primary color.